

EAST Search History

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L1	69601	edge near4 detect\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:05
L2	7680	(edge near4 detect\$4) with direction	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:06
L3	157	(edge near4 detect\$4) with direction and (coefficient with correct\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:07
L4	6	(edge near4 detect\$4) with direction with left and (coefficient with correct\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:16
L5	8	(edge near4 detect\$4) with left with horizontal and (coefficient with correct\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:22
L6	753	382/266.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:23
L7	101	382/266.ccls. and (left near3 (edge or contour))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:23
L8	40	382/266.ccls. and (left near3 (edge or contour)) and (coefficient)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:28

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L9	5	382/266.ccls. and (left near3 (edge or contour)) and (coefficient with correct\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/18 15:28
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IEEE STD IEEE Standard

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Medical Imaging, IEEE Transactions on
 Volume 16, Issue 1, Feb. 1997 Page(s):87 - 95
 Digital Object Identifier 10.1109/42.552058

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2. **Analysis of position-dependent Compton scatter in scintimammography compression**

Williams, M.B.; Narayanan, D.; More, M.J.; Goodale, P.J.; Majewski, S.; Kiepe
Nuclear Science Symposium Conference Record, 2002 IEEE
 Volume 2, 10-16 Nov. 2002 Page(s):863 - 867 vol.2
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Debing Yang; Wang, D.D.; Jinwu Xu; Jianxin Hua; Yaohuan Xu;
Industrial Technology, 1996. (ICIT '96), Proceedings of The IEEE International
 2-6 Dec. 1996 Page(s):455 - 459
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4. **Analysis of position-dependent Compton scatter in scintimammography compression**

Williams, M.B.; Narayanan, D.; More, M.J.; Goodale, P.J.; Majewski, S.; Kiepe
Nuclear Science, IEEE Transactions on
 Volume 50, Issue 5, Part 2, Oct. 2003 Page(s):1643 - 1649
 Digital Object Identifier 10.1109/TNS.2003.817297

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Shah, S.; Aggarwal, J.K.;
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